

N-Channel Enhancement Mode Field Effect Transistor with Schottky Diode

General Description

The VB3222A uses advanced trench technology to provide excellent R $_{DS(ON)}$ and low gate charge. A Schottky diode is provided to facilitate the implementation of a bidirectional blocking switch, or for DC-DC conversion applications.

Features

 $V_{DS}(V) = 20V$

 $I_D = 6.0A \ (V_{GS} = 4.5V)$

 $R_{DS(ON)}$ < 26m Ω (V_{GS} = 4.5V)

 $R_{DS(ON)}$ < 35m Ω (V_{GS} = 2.5V)

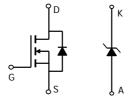
 $R_{DS(ON)}$ < 45m Ω (V_{GS} = 1.8V)

SCHOTTKY

 $V_{DS}(V) = 20V, I_F = 1A, V_F < 0.5V @ 0.5A$







Absolute Maximum Ratings T _A =25°C unless otherwise noted							
Parameter		Symbol	MOSFET	Schottky	Units		
Drain-Source Voltage		V_{DS}	20		V		
Gate-Source Voltage		V_{GS}	±8		V		
	T _A =25°C		6.0				
Continuous Drain Current ^A	T _A =70°C	I _D	4.5		Α		
Pulsed Drain Current B		I _{DM}	18				
Schottky reverse voltage		V_{KA}		20	V		
	T _A =25°C	I _F		2			
Continuous Forward Current ^A	T _A =70°C	I IF		1	Α		
Pulsed Forward Current B		I _{FM}		10	1		
	T _A =25°C	P _D	1.50	1.0	W		
Power Dissipation	T _A =70°C	' ⁻ D	0.9	0.6	VV		
Junction and Storage Temperature Range		T_J, T_{STG}	-55 to 150	-55 to 150	°C		

Parameter: Thermal Characteris	tics MOSFET	Symbol	Тур	Max	Units		
Maximum Junction-to-Ambient ^A	t ≤ 10s	$R_{ hetaJA}$	80.3	110			
Maximum Junction-to-Ambient ^A	Steady-State	ТθЈА	117	150	°C/W		
Maximum Junction-to-Lead ^C	Steady-State	$R_{\theta JL}$	43	80			
Thermal Characteristics Schottky							
Maximum Junction-to-Ambient ^A	t ≤ 10s	$R_{\scriptscriptstyle{ hetaJA}}$	109.4	135			
Maximum Junction-to-Ambient ^A	Steady-State	ТθЈА	136.5	175	°C/W		
Maximum Junction-to-Lead ^C	Steady-State	$R_{\theta JL}$	58.5	80			



Electrical Characteristics (T J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
STATIC I	PARAMETERS			•	=	=
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0V$	20			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =16V, V _{GS} =0V			1	μА
DSS	Zero Gate Voltage Drain Gurrent	T _J =55°C			5	μΑ
I _{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} =±8V			100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_D=250\mu A$	0.4		1.5	V
$I_{D(ON)}$	On state drain current	V _{GS} =4.5V, V _{DS} =5V	10			Α
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =4.5V, I _D =3.8A		23		mΩ
		T _J =125°C		42		1115.2
US(ON)		V_{GS} =2.5V, I_{D} =3.3A		27		mΩ
		V_{GS} =1.8V, I_{D} =2.8A		40		mΩ
g _{FS}	Forward Transconductance	V_{DS} =5V, I_D =3.8A		10.5		S
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V		0.8	1	V
Is	Maximum Body-Diode Continuous Curre	ent			1.8	Α
DYNAMI	CPARAMETERS					
C _{iss}	Input Capacitance			449		pF
Coss	Output Capacitance	V _{GS} =0V, V _{DS} =10V, f=1MHz		74		pF
C _{rss}	Reverse Transfer Capacitance			51.6		pF
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz		4.9		Ω
SWITCH	NG PARAMETERS					
Q_g	Total Gate Charge			5.9		nC
Q_{gs}	Gate Source Charge	V_{GS} =4.5V, V_{DS} =10V, I_{D} =3.8A		0.36		nC
Q_{gd}	Gate Drain Charge]		1.3		nC
t _{D(on)}	Turn-On DelayTime			4.5		ns
t _r	Turn-On Rise Time	V_{GS} =5V, V_{DS} =10V, R_L =2.6 Ω ,		6		ns
t _{D(off)}	Turn-Off DelayTime	R_{GEN} = 0Ω		32.7		ns
t _f	Turn-Off Fall Time			7.1		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =3.8A, dI/dt=100A/μs		13		ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =3.8A, dI/dt=100A/μs		3.3		nC
SCHOTT	KY PARAMETERS					
V _F	Forward Voltage Drop	I _F =0.5A		0.39	0.5	V
	Maximum rayaraa laakaga aurrant	V _R =16V			0.02	- mA
I _{rm}	Maximum reverse leakage current	V _R =16V, T _J =125°C			20	
C _T	Junction Capacitance	V _R =10V		34		pF
t _{rr}	SchottkyReverse Recovery Time	I _F =1A, dI/dt=100A/μs		5.2	10	ns
Q _{rr}	Schottky Reverse Recovery Charge	I _F =1A, dI/dt=100A/μs		0.8		nC

A: The value of R_{0JA} is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t ≤ 10s thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

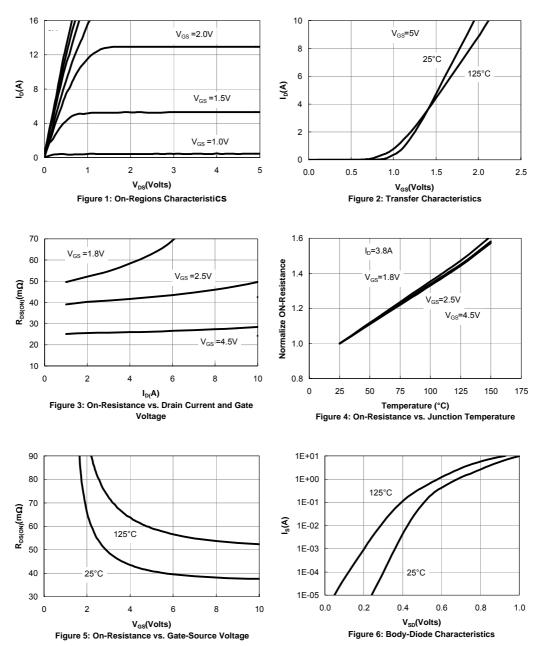
C. The R $_{\theta,JA}$ is the sum of the thermal impedence from junction to lead R $_{\theta,JL}$ and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using 80µs pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C. The SOA curve provides a single pulse rating.



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





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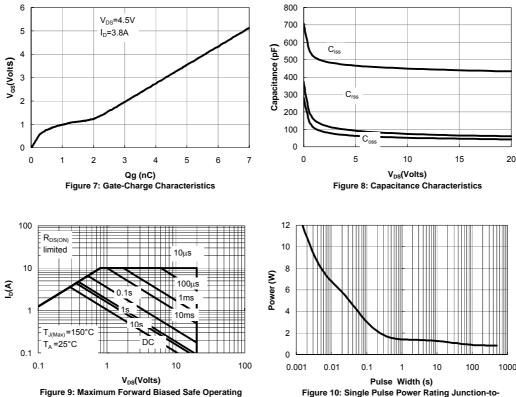
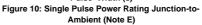


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)



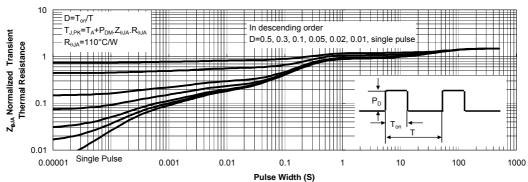


Figure 11: Normalized Maximum Transient Thermal Impedence



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS: SCHOTTKY

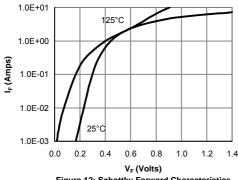


Figure 12: Schottky Forward Characteristics

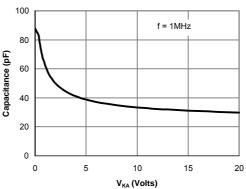


Figure 13: Schottky Capacitance Characteristics

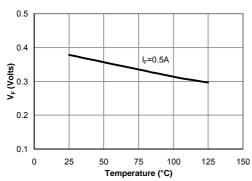


Figure 14: Schottky Forward Drop vs. Junction Temperature

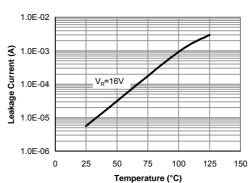


Figure 15: Schottky Leakage current vs. Junction Temperature

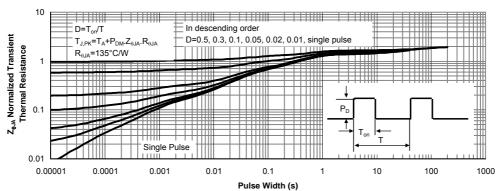
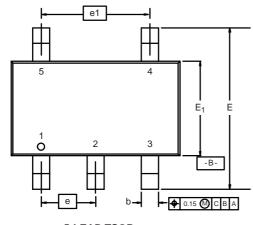


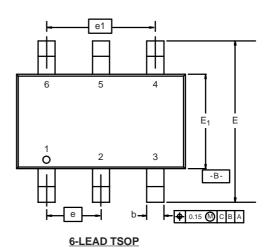
Figure 15: Schottky Normalized Maximum Transient Thermal Impedance



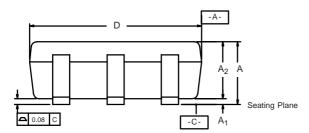
TSOP: 5/6-LEAD

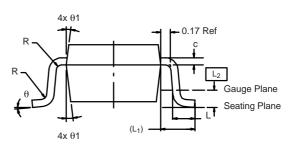
JEDEC Part Number: MO-193C





5-LEAD TSOP





	MILLIMETERS			INCHES				
Dim	Min	Nom	Max	Min	Nom	Max		
Α	0.91	-	1.10	0.036	-	0.043		
A ₁	0.01	-	0.10	0.0004	-	0.004		
A ₂	0.90	-	1.00	0.035	0.038	0.039		
b	0.30	0.32	0.45	0.012	0.013	0.018		
С	0.10	0.15	0.20	0.004	0.006	0.008		
D	2.95	3.05	3.10	0.116	0.120	0.122		
Е	2.70	2.85	2.98	0.106	0.112	0.117		
E ₁	1.55	1.65	1.70	0.061	0.065	0.067		
е		0.95 BSC			0.0374 BSC			
e ₁	1.80	1.90	2.00	0.071	0.075	0.079		
L	0.32	-	0.50	0.012	-	0.020		
L ₁	0.60 Ref			0.024 Ref				
L ₂	0.25 BSC			0.010 BSC				
R	0.10	-	-	0.004	-	-		
θ	0°	4°	8°	0°	4°	8°		
θ_1	7° Nom			7° Nom				
ECN: C-06593-Rev. I, 18-Dec-06 DWG: 5540								



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